



Material No.: 5367-03 Batch No.: 0000032444

Manufactured Date: 2013/01/02

Retest Date: 2018/01/01

Certificate of Analysis

Test	Specification	Result
Assay (as HCl) (by acid-base titrn)	37.0 - 38.0 %	37.7
Color (APHA)	<= 10	6
Residue after Ignition	<= 3 ppm	<1
Extractable Organic Substances	<= 3 ppm	<1
Bromide (Br)	<= 0.005 %	< 0.005
Free Halogen (as Cl2)	Passes Test	PT
Ammonium (NH4)	<= 1 ppm	<1
Phosphate (PO ₄)	<= 0.05 ppm	< 0.03
Sulfate (SO ₄)	<= 0.3 ppm	0.3
Sulfite (SO₃)	<= 0.8 ppm	0.2
Trace Impurities – Aluminum (Al)	<= 100.0 ppb	< 5.0
Arsenic and Antimony (as As)	<= 5 ppb	< 3
Trace Impurities – Barium (Ba)	<= 20.0 ppb	< 1.0
Trace Impurities – Beryllium (Be)	<= 10.0 ppb	< 1.0
Trace Impurities – Bismuth (Bi)	<= 20.0 ppb	< 10.0
Trace Impurities – Boron (B)	<= 20.0 ppb	< 5.0
Trace Impurities – Cadmium (Cd)	<= 5.0 ppb	< 1.0
Trace Impurities – Calcium (Ca)	<= 100.0 ppb	19.2
Trace Impurities – Chromium (Cr)	<= 50.0 ppb	< 1.0
Trace Impurities - Cobalt (Co)	<= 5.0 ppb	< 1.0
Trace Impurities – Copper (Cu)	<= 5.0 ppb	< 1.0
Trace Impurities – Gallium (Ga)	<= 20.0 ppb	< 1.0
Trace Impurities – Germanium (Ge)	<= 20.0 ppb	< 10.0
Trace Impurities - Gold (Au)	<= 20.0 ppb	< 5.0

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Heavy Metals (as Pb)	<= 100 ppb	<5
Trace Impurities – Iron (Fe)	<= 50.0 ppb	12.7
Trace Impurities - Lead (Pb)	<= 25.0 ppb	< 10.0
Trace Impurities - Lithium (Li)	<= 50.0 ppb	< 1.0
Trace Impurities - Magnesium (Mg)	<= 50.0 ppb	< 1.0
Trace Impurities - Manganese (Mn)	<= 5.0 ppb	< 1.0
Trace Impurities - Molybdenum (Mo)	<= 10.0 ppb	< 5.0
Trace Impurities - Nickel (Ni)	<= 10.0 ppb	< 5.0
Trace Impurities - Niobium (Nb)	<= 10.0 ppb	< 1.0
Trace Impurities – Potassium (K)	<= 100.0 ppb	< 10.0
Trace Impurities – Silicon (Si)	<= 100.0 ppb	< 10.0
Trace Impurities – Silver (Ag)	<= 20.0 ppb	< 1.0
Trace Impurities - Sodium (Na)	<= 100.0 ppb	12.9
Trace Impurities – Strontium (Sr)	<= 20.0 ppb	< 1.0
Trace Impurities – Tantalum (Ta)	<= 10.0 ppb	< 5.0
Trace Impurities - Thallium (Tl)	<= 20.0 ppb	< 5.0
Trace Impurities – Tin (Sn)	<= 50.0 ppb	< 10.0
Trace Impurities – Titanium (Ti)	<= 10.0 ppb	< 1.0
Trace Impurities - Vanadium (V)	<= 10.0 ppb	< 1.0
Trace Impurities – Zinc (Zn)	<= 50.0 ppb	< 1.0
Trace Impurities – Zirconium (Zr)	<= 10.0 ppb	< 1.0
Particle Count - 0.5 µm and greater	<= 50 par/ml	3
Particle Count - 1.0 µm and greater	<= 10 par/ml	<1

For Microelectronic Use

Reported value is the average of all samples counted for this lot number, with no individual sample value exceeding the specification.

Country of Origin: US

Packaging Site: Paris Mfg Ctr & DC



Phillipsburg, NJ 9001:2008, 14001:2004 Paris, KY 9001:2008 Mexico City, Mexico 9001:2008 Deventer, The Netherlands 9001:2008, 14001:2004, 13485:2003 Gliwice, Poland 9001:2008, 17025:2005 Selangor, Malaysia 9001:2008 Dehradun, India, 9001:2008, 14001:2004, 13485:2003 Mumbai, India, 9001:2008, 17025:2005 Panoli, India 9001:2008

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Global Director of Quality Assurance